## Search Notes



10730048

Applicant(s)/Patent Under Reexamination

HOSHINO ET AL.

Examiner

Yu, Gina C

Art Unit

1617

## **SEARCHED**

Class	Subclass	Date	Examiner
514	616	5/15/06	gy
424	401		

<b>SEARCH</b>	NOTES
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	Search Notes	Date	Examiner
pare	40/000445	5/15/07	gy

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner